

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/611,796	ELBOIM, YARON	
Examiner	Art Unit	
Harold Kim	2182	

SEARCHED					
Class	Subclass	Date	Examiner		
710	29, 52, 57, 58, 60	11/13/2005	НК		
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPAT, USPBPUB, JPO, EPO, IEEE, NPL, PLUS, inventor search on eDan	11/13/2005	нк
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